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Insights from scanning tunneling microscopy experiments into correlated electron systems

Benschop, T.

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Insights from Scanning Tunneling Microscopy Experiments into Correlated Electron Systems

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Tjerk Benschop

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Promotores:

Dr. M.P. Allan

Prof. dr. J. Aarts

Promotiecommissie:

Dr. M. Rösner

(Radboud Universiteit Nijmegen)

Prof. dr. C. Schönenberger

(University of Basel)

Dr. S. Bhattacharyya

Prof. dr. E.R. Eliel

Prof. dr. ir. S.J. van der Molen



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